Search Notes

P	Application/Control No.	Applicant(s)/Pate Reexamination	Applicant(s)/Patent under Reexamination	
1	10/628,723	LIM, JEONG C	HAN	
E	Examiner	Art Unit		
	Dean J. Kramer	3652		

	SEAR	CHED	
Class	Subclass	Date	Examiner
294	64./ 65 81.6 81.62	7/12/05	DIK
	81.62 87.1		
901	40		
414	627 737 752-1		

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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